

Search Notes

Application/Control No.

10/760,426

Examiner

Sam K. Ahn

Applicant(s)/Patent under
Reexamination

MUTOH, MASAHIKO

Art Unit

2611

SEARCHED

Class	Subclass	Date	Examiner
375	142,143,1 50,152,34 3	1/20/2007	SA
324	76.33	1/20/2007	SA
708	5,422,813	1/20/2007	SA

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST - inventor search, keyword and citation search IEEE and goole - keyword and citation search consulted Young Tse, 375 P.E	1/20/2007	SA